

Application/Control No.	Applicant(s)/Patent under Reexamination	r
10/601,655	NAKAHARA, SHIGEKI	
Examiner	Art Unit	
Madeleine AV Nguyen	2625	

	SEARCHED				
Class	Subclass	Date	Examiner		
update		3/31/2006	AV		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		 -		

(INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
East	3/31/2006	AV			